


<b>Search Notes</b>  	<b>Application/Control No.</b>  10698666	<b>Applicant(s)/Patent Under Reexamination</b>  HUSTED, PAUL J.
	<b>Examiner</b>  Lee, Siu M	<b>Art Unit</b>  2611

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
375	341, 345, 262, 137, 355, 316, 340, 260, 343, 365, 346, 368, 234, 324, 347, 130	3/7/2007	Siu M. Lee

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST	3/7/2007	Siu M. Lee
Discuss application with Chieh Fan	3/12/2007	Siu M. Lee
EAST	8/6/2007	Siu M. Lee
Discuss with Chieh Fan	8/6/2007	Siu M. Lee

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>